UNISONIC TECHNOLOGIES CO., LTD

5N65-CQ **Preliminary Power MOSFET**

5A, 650V N-CHANNEL **POWER MOSFET**

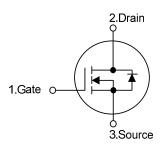
DESCRIPTION

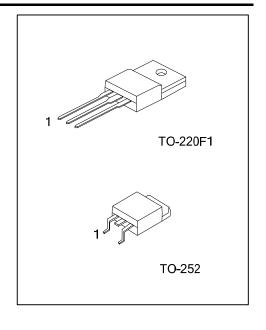
The UTC 5N65-CQ is a high voltage power MOSFET designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and high rugged avalanche characteristics. This power MOSFET is usually used in high speed switching applications of switching power supplies and adaptors.

FEATURES

- * $R_{DS(ON)}$ < 2.2 Ω @ V_{GS} = 10 V, I_D = 2.5 A
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness

SYMBOL

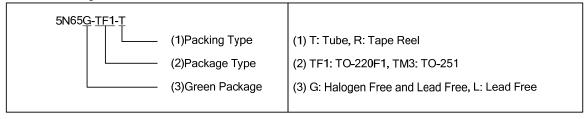




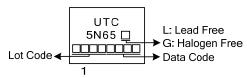
ORDERING INFORMATION

Ordering Number		Daakaga	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
5N65L-TF1-T	5N65G-TF1-T	TO-220F1	G	D	S	Tube	
5N65L-TN3-R	5N65G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate S: Source D: Drain



MARKING



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■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	650	V	
Gate-Source Voltage		V_{GSS}	±30	V	
Continuous Drain Current		I_{D}	5	Α	
Pulsed Drain Current (Note 2)		I_{DM}	20	Α	
Avalanche Energy	Single Pulsed (Note 3)	sed (Note 3) E _{AS} 64		mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	3.4	V/ns	
Power Dissipation	TO-220F1	D	36	W	
	TO-252	P _D	54	W	
Junction Temperature		T _J	+150	°C	
Storage Temperature		T_{STG}	-55 ~ + 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 16mH, I_{AS} = 2.82A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25°C
- 4. $I_{SD} \le 5.0 A$, di/dt $\le 200 A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25 ^{\circ}C$

■ THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT	
Junction to Ambient	TO-220F1	0	62.5	°C/W	
	TO-252	θ_{JA}	160		
Junction to Case	TO-220F1	θ_{JC}	3.47	°C/A/	
	TO-252		2.3	°C/W	

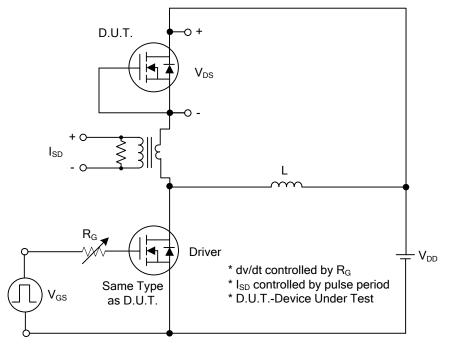
■ **ELECTRICAL CHARACTERISTICS** (T_J =25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV _{DSS}	$V_{GS} = 0V, I_D = 250\mu A$	650			V	
Drain-Source Leakage Current		I _{DSS}	$V_{DS} = 650V, V_{GS} = 0V$			10	μA	
Gate- Source Leakage Current	Forward		$V_{GS} = 30V, V_{DS} = 0V$			100	nA	
	Reverse	I_{GSS}	$V_{GS} = -30V, V_{DS} = 0V$			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	$V_{GS} = 10V, I_D = 2.5A$			2.2	Ω	
DYNAMIC CHARACTERISTICS								
Input Capacitance		C _{ISS}	V _{DS} =25V, V _{GS} =0V,		528		pF	
Output Capacitance		Coss	f=1.0 MHz		70		pF	
Reverse Transfer Capacitance		C_{RSS}	1-1.0 1/11 12		9		pF	
SWITCHING CHARACTERISTICS	S							
Total Gate Charge		Q_G	\\ _E0\\ \\ _10\\ _1 3 A		46		nC	
Gate-Source Charge		Q_GS	V _{DS} =50V, V _{GS} =10V, I _D =1.3A, I _D =100µA (Note 1, 2)		4.2		nC	
Gate-Drain Charge		Q_GD	ΠΔ-100μΑ (Note 1, 2)		7		nC	
Turn-On Delay Time		$t_{D(ON)}$			46		ns	
Turn-On Rise Time		t_R	V_{DD} =30V, V_{GS} =10V, I_{D} =0.5A,		50		ns	
Turn-Off Delay Time		t _{D(OFF)}	$R_G = 25\Omega$ (Note 1, 2)		160		ns	
Turn-Off Fall Time		t_{F}			46		ns	
DRAIN-SOURCE DIODE CHARA	CTERISTIC	CS AND MAXII	MUM RATINGS					
Maximum Continuous Drain-Source Diode		I _S				5	Α	
Forward Current						3	^	
Maximum Pulsed Drain-Source Diode		I _{SM}				20	Α	
Forward Current						20	^	
Drain-Source Diode Forward Voltage		V_{SD}	I _S =5.0A , V _{GS} =0V			1.4	V	
Body Diode Reverse Recovery Time		t _{rr}	I _S =5.0A , V _{GS} =0V		264		ns	
Body Diode Reverse Recovery Charge		Q_{rr}	di/dt=100A/µs		1.62		μC	

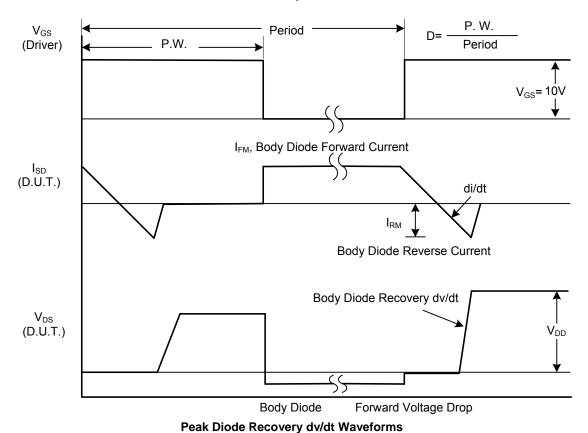
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

^{2.} Essentially independent of operating temperature

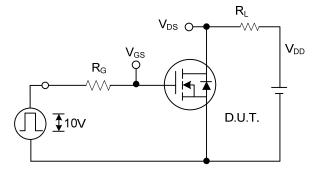
■ TEST CIRCUITS AND WAVEFORMS



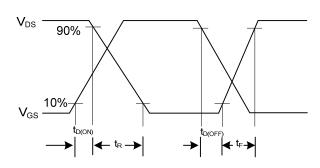
Peak Diode Recovery dv/dt Test Circuit



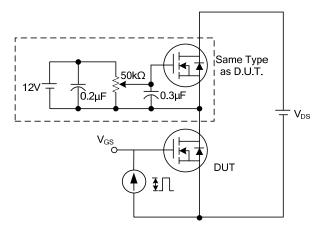
■ TEST CIRCUITS AND WAVEFORMS (Cont.)



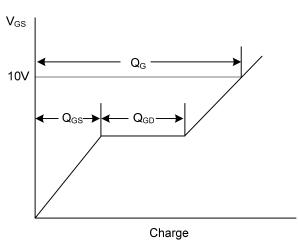
Switching Test Circuit



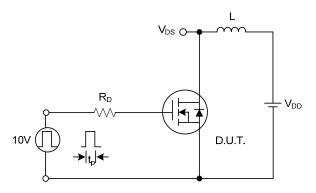
Switching Waveforms



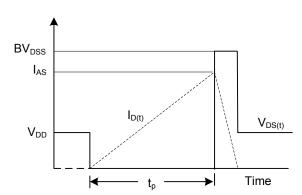
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

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